Monoclinic $P2_1/c$
a = 8.814 (1) Å
$b = 8.718 (1) \text{ Å}_{a}$
c = 22.125 (2) Å
$\beta = 90.80 (1)^{\circ}$
V = 1699.9 (3) Å ³
Z = 4
$D_x = 1.445 \text{ Mg m}^{-3}$
D_m not measured

Data collection

Siemens P4 diffractometer $\theta/2\theta$ scans Absorption correction: none 5267 measured reflections 3908 independent reflections 2924 reflections with $I > 2\sigma(I)$ $R_{int} = 0.024$

Refinement

Refinement on F^2 $(\Delta/\sigma)_{max} < 0.001$ $R[F^2 > 2\sigma(F^2)] = 0.039$ $\Delta \rho_{max} = 0.30 \text{ e} \text{ Å}^{-3}$ $wR(F^2) = 0.111$ $\Delta \rho_{min} = -0.30 \text{ e} \text{ Å}^{-3}$ S = 0.962Extinction correction: none3908 reflectionsScattering factors from300 parametersInternational Tables forAll H atoms refinedCrystallography (Vol. C) $w = 1/[\sigma^2(F_o^2) + (0.0705P)^2]$ where $P = (F_o^2 + 2F_c^2)/3$

Table 1. Selected geometric parameters (Å, °)

	(I)	(II)
Cl-C20	1.749 (5)	1.741 (2)
S—C12	1.747 (4)	1.733 (2)
S—C1	1.752 (5)	1.740 (2)
C6—C7	1.413 (7)	1.434 (2)
C7—C12	1.379 (6)	1.383 (2)
C7—C8	1.422 (6)	1.420 (2)
C8—N13	1.335 (6)	1.326 (2)
C8—N9	1.377 (6)	1.374 (2)
N9—N15	1.376 (5)	1.374 (2)
N9-C10	1.385 (6)	1.382 (2)
C10-N11	1.303 (6)	1.306 (2)
C10—N16	1.349 (6)	1.358 (2)
N11-C12	1.363 (6)	1.365 (2)
N13-C14	1.352 (7)	1.372 (2)
C14—N15	1.323 (7)	1.317 (2)
C14—C23		1.488 (2)
N16—C17	1.413 (6)	1.412 (2)
C12—S—C1	91.1 (2)	91.20 (8)
C10-N16-C17	129.7 (4)	128.27 (14)

Disorder in the cyclohexene rings was detected during refinement from the large displacement ellipsoids of C3 in (I) and of C3 and C4 in (II). The positional and occupancy parameters of the alternative sites were refined. The displacement parameters of the alternative sites were set equal during the final stages of the refinement. The populations of the major conformers are 94 (1) and 92 (1)% for (I) and (II), respectively. The bond lengths associated with the minor component atoms [C3' in (I), and C3' and C4' in (II)] were made equal to those for the major component atoms using *DFIX* (Sheldrick, 1993).

For both compounds, data collection: XSCANS (Siemens, 1994); cell refinement: XSCANS; data reduction: XSCANS; program(s) used to solve structures: SHELXTL/PC (Sheldrick,

Cell parameters from 32 reflections $\theta = 8-25^{\circ}$ $\mu = 0.359 \text{ mm}^{-1}$ T = 293 (2) K Needle $0.58 \times 0.38 \times 0.08 \text{ mm}$ Colourless

 $\theta_{\rm max} = 27.5^{\circ}$

 $h = -1 \rightarrow 11$

 $k = -1 \rightarrow 11$

 $l = -28 \rightarrow 28$

3 standard reflections

every 97 reflections

intensity decay: <4%

1990); program(s) used to refine structures: *SHELXL*93 (Sheldrick, 1993) and *PARST* (Nardelli, 1983); molecular graphics: *SHELXTL/PC*; software used to prepare material for publication: *SHELXL*93.

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Supplementary data for this paper are available from the IUCr electronic archives (Reference: MU1295). Services for accessing these data are described at the back of the journal.

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2,12-Dibromo-5,6-dihydrodibenz[*c*,*h*]acridine

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Abstract

The butterfly-like title molecule, $C_{21}H_{13}Br_2N$, is almost planar except for the cyclohexadiene ring which is in a half-chair conformation.

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$C_{21}H_{13}Br_2N$

Comment

Macrocyclic polyazaarenes are important host molecules for guest-host complexation (Ray, Roy & Kar, 1996). The dibromo derivative is unique in connecting the two halves to form a macrocyclic network. We have prepared the title compound, (I), from bromonaphthylamine and bromotetralone (Ray & Haldar, 1997), and performed an X-ray study in order to establish the structure and conformation of the molecule.



The cyclohexadiene ring (C9-C12, C17, C18) adopts a half-chair conformation, with atoms C10 and C11 deviating by 0.298(5) and -0.357(6)Å, respectively, from the mean plane formed by the remaining atoms in the ring; the asymmetry parameter ΔC_2 (C10–C11) is $0.011(2)^{\circ}$ (Nardelli, 1983a). The planarity of the molecule is disturbed by the cyclohexane ring and the two planar segments on either side of it make a dihedral angle of $158.0(1)^\circ$. The aromatic C—C distances vary from 1.339(8) to 1.474(5) Å, with an average value of 1.397 (6) Å. The shortest intermolecular methylene C···N contacts are C10···N1($\frac{3}{2} - x$, $y + \frac{1}{2}$, $\frac{1}{2} - z$) 3.638 (6) and C11···N1($\frac{3}{2} - x$, $y - \frac{1}{2}$, $\frac{1}{2} - z$) 3.624 (7) Å.



Fig. 1. The structure of title compound showing 50% probability displacement ellipsoids and the atom-numbering scheme.

Experimental

Single crystals of the title compound were obtained by slow cooling of a chloroform and petroleum ether solvent system.

Crystal data

$C_{21}H_{13}Br_2N$	Mo $K\alpha$ radiation
$M_r = 439.14$	$\lambda = 0.71073 \text{ Å}$

C2/ca = 18.262(2) Å b = 7.0960(10) Å c = 26.315(2) Å $\beta = 105.090 (10)^{\circ}$ V = 3292.5 (6) Å³ Z = 8 $D_x = 1.772 \text{ Mg m}^{-3}$ D_m not measured

Data collection

Siemens P4 diffractometer $\theta/2\theta$ scans Absorption correction: empirical ψ scans (XSCANS; Siemens, 1994) $T_{\rm min} = 0.671, T_{\rm max} = 0.909$ 4737 measured reflections 3732 independent reflections 1897 reflections with $I > 2\sigma(I)$

Refinement

Refinement on F^2 $(\Delta/\sigma)_{\rm max} < 0.001$ $\Delta \rho_{\rm max} = 0.678 \ {\rm e} \ {\rm \AA}^{-3}$ $R[F^2 > 2\sigma(F^2)] = 0.041$ $wR(F^2) = 0.103$ $\Delta \rho_{\rm min} = -0.533 \ {\rm e} \ {\rm \AA}^{-3}$ S = 0.865Extinction correction: none 3730 reflections Scattering factors from 269 parameters International Tables for All H atoms refined Crystallography (Vol. C) $w = 1/[\sigma^2(F_o^2) + (0.0451P)^2]$ where $P = (F_o^2 + 2F_c^2)/3$

Cell parameters from 28

 $0.72 \times 0.36 \times 0.32$ mm

reflections

 $\theta = 5.44 - 12.47^{\circ}$

 $\mu = 4.925 \text{ mm}^{-1}$

T = 293 (2) K

Light yellow

 $R_{int} = 0.037$

 $\theta_{\rm max} = 27.49^{\circ}$

 $h = -1 \rightarrow 23$

 $k = -1 \rightarrow 9$ $l = -34 \rightarrow 33$

3 standard reflections

every 97 reflections

intensity decay: <3%

Slab

Table 1. Selected geometric parameters (Å, °)

Br1—C1	1.896 (4)	C8—C9	1.357 (6)
Br2C15	1.907 (4)	C9-C18	1.407 (5)
NI-C18	1.336 (5)	C9-C10	1.507 (6)
N1-C19	1.354 (4)	C10-C11	1.494 (7)
C1-C21	1.371 (6)	C11—C12	1.497 (6)
C1C2	1.397 (6)	C12C13	1.393 (6)
C2—C3	1.347 (7)	C12—C17	1.415 (5)
C3C4	1.411 (6)	C13-C14	1.359 (6)
C4-C20	1.415 (5)	C14—C15	1.386 (6)
C4—C5	1.427 (6)	C15—C16	1.367 (5)
C5-C6	1.339 (7)	C16C17	1.392 (5)
C6—C7	1.428 (6)	C17—C18	1.474 (5)
C7—C8	1.400 (6)	C19—C20	1.459 (5)
C7—C19	1.403 (5)	C20-C21	1.394 (6)
C8—C7—C6	123.1 (4)	NI-C18-C9	123.2 (4)
C8-C9-C10	122.2 (4)	N1-C18-C17	118.0 (3)
С11-С10-С9	111.6 (4)	N1-C19-C7	122.7 (4)
C13C12C11	122.5 (4)		

The structure was solved by direct methods and refined by full-matrix least-squares techniques. All H atoms were located from difference Fourier maps and refined isotropically.

Programs used: data collection, cell refinement and data reduction: XSCANS (Siemens, 1994); structure solution and molecular graphics: SHELXTL/PC (Sheldrick, 1990); structure refinement: SHELXL93 (Sheldrick, 1993); geometrical calculations: PARST (Nardelli, 1983b).

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Supplementary data for this paper are available from the IUCr electronic archives (Reference: MU1331). Services for accessing these data are described at the back of the journal.

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Comment

Rhodamine 6G, with its excellent photophysical properties, has found extensive applications in tunable lasers (Hung & Meyer, 1992; Wittmann, Penzkofer & Baeumler, 1992), fluorescence depolarization diagnostic devices (Herz, 1974), photographic technology (Norland, Ames & Taylor, 1970) and electroluminescent devices (Johnson & McGrane, 1993). Furthermore, it can be used in concentrators of solar diagnostic devices (Batchelder, Zewail & Cole, 1979; Bhownik, Huri & Rohatgi-Mukherjee, 1987). The structure of the dye influences the molecular aggregation and also affects the absorption and emission properties (Ojeda, Katime, Ochoa & Arbeloa, 1988; Arbeloa, Aguirresacona & Arbeloa, 1989). In order to ascertain the structures of rhodamine 6G and its analogous complexes, we obtained crystals of the title compound, (I), from rhodamine 6G and ZnI₂.6H₂O by ion-exchange reaction. To our knowledge, this is the first crystal structure report on a rhodamine derivative.



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N-[9-(2-Ethoxycarbonylphenyl)-6-(ethylamino)-2,7-dimethyl-3-xanthenylidene]ethylammonium Iodide Monohydrate

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Abstract

The xanthene moiety in the title compound, $C_{28}H_{31}$ - $N_2O_3^*.I^-.H_2O$, is planar, with the attached phenyl ring twisted by $-78.8~(6)^\circ$ from the molecular plane. Of the two ethylamino groups, one is coplanar and the other makes a dihedral angle of $152.1~(5)^\circ$ with the xanthene ring system. The positive charge of the cation is delocalized and both N— C_{sp^2} bonds show double-bond character.

A displacement ellipsoid plot of (I) with the atomnumbering scheme is shown in Fig. 1. The xanthene moiety is planar, with the C2 atom showing the largest out-of-plane displacement of 0.075(5) Å; the phenyl ring is twisted from the xanthene moiety by $-78.8(6)^{\circ}$. While one ethylamino group is almost coplanar with the xanthene moiety, the other makes a dihedral angle of $152.1(5)^{\circ}$ with it. The mean



Fig. 1. The molecular structure of (I) showing 50% probability displacement ellipsoids and the atom-numbering scheme. H atoms are not shown.

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